

**Notice of References Cited**

Application/Control No.

09/816,559

Applicant(s)/Patent Under  
Reexamination  
CHEN ET AL.

Examiner

DANH C LE

Art Unit

2683

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**U.S. PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
	A	US-5,615,409	03-1997	Forssen et al.	455/440
	B	US-6,349,217	02-2002	Honcharenko et al.	455/562.1
	C	US-6,249,251	06-2001	Chang et al.	342/378
	D	US-6,466,166	10-2002	Nakagawa, Takashi	342/378
	E	US-6,522,898	02-2003	Kohno et al.	455/562.1
	F	US-			
	G	US-			
	H	US-			
	I	US-			
	J	US-			
	K	US-			
	L	US-			
	M	US-			

**FOREIGN PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N					
	O					
	P					
	Q					
	R					
	S					
	T					

**NON-PATENT DOCUMENTS**

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
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	V	
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	X	

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